

# IGBT - Power, Co-PAK N-Channel, Field Stop VII (FS7), Non SCR, Power TO247-3L, 1200 V, 1.7 V, 75 A

# FGY75T120SWD

## Description

Using the novel field stop 7<sup>th</sup> generation IGBT technology and the Gen7 Diode in TO247 3–lead package, FGY75T120SWD offers the optimum performance with low switching and conduction losses for high–efficiency operations in various applications like Solar, UPS and ESS.

#### **Features**

- Maximum Junction Temperature  $T_J = 175$ °C
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Smooth and Optimized Switching
- Low Switching Loss
- RoHS Compliant

### **Applications**

- Boost and Inverter in Solar System
- UPS
- Energy Storage System

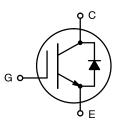
### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

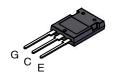
| Parameter                                  | Symbol   | Value           | Unit |   |
|--|--|-----------------|------|---|
| Collector to Emitter Voltage               | V <sub>CES</sub>   | 1200            | V    |   |
| Gate to Emitter Voltage                    |  | $V_{GES}$       | ±20  |   |
| Transient Gate to Emitter                  | Voltage  |                 | ±30  |   |
| Collector Current T <sub>C</sub> = 25°C    |  | Ic              | 150  |   |
|  | T <sub>C</sub> = 100°C                                     |                 | 75   | Α |
| Power Dissipation                          | T <sub>C</sub> = 25°C                                      | $P_{D}$         | 503  | W |
|  | T <sub>C</sub> = 100°C                                     |                 | 251  |   |
| Pulsed Collector<br>Current                | $T_{C} = 25^{\circ}C,$<br>$t_{p} = 10 \ \mu s$<br>(Note 1) | I <sub>CM</sub> | 300  | Α |
| Diode Forward                              | T <sub>C</sub> = 25°C                                      | I <sub>F</sub>  | 150  |   |
| Current                                    | T <sub>C</sub> = 100°C                                     |                 | 75   |   |
| Pulsed Diode<br>Maximum Forward<br>Current | $T_{C} = 25^{\circ}C,$<br>$t_{p} = 10 \ \mu s$<br>(Note 1) | I <sub>FM</sub> | 300  |   |
| Operating Junction and St<br>Temperature   | T <sub>J</sub> , T <sub>STG</sub>                          | -55 to 175      | °C   |   |
| Lead Temperature for Solo                  | $T_L$  | 260             |      |   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

| BV <sub>CES</sub> | V <sub>CE(SAT)</sub> | I <sub>C</sub> |
|-------------------|----------------------|----------------|
| 1200 V            | 1.7 V                | 75.0 A         |

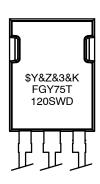
### **PIN CONNECTIONS**





TO247-3LD CASE 340CD

### **MARKING DIAGRAM**



 \$Y
 = onsemi Logo

 &Z
 = Assembly Plant Code

 &3
 = 3-Digit Date Code

 &K
 = 2-Digit Lot Traceability Code

 FGY75T120SWD
 = Specific Device code

#### **ORDERING INFORMATION**

| Device       | Package                | Shipping           |
|--------------|------------------------|--------------------|
| FGY75T120SWD | TO247-3LD<br>(Pb-Free) | 30 Units /<br>Tube |

<sup>1.</sup> Repetitive rating: pulse width limited by max. Junction temperature.

## THERMAL CHARACTERISTICS

| Parameter                                      | Symbol         | Max Value | Unit |
|--|----------------|-----------|------|
| Thermal Resistance, Junction to Case for IGBT  | $R_{	heta JC}$ | 0.3       | °C/W |
| Thermal Resistance, Junction to Case for Diode |                | 0.4       |      |
| Thermal Resistance, Junction to Ambient        | $R_{	heta JA}$ | 40        |      |

# **ELECTRICAL CHARACTERISTICS OF THE IGBT** ( $T_J = 25$ °C unless otherwise noted)

| Parameter                                    | Symbol                             | Test Conditions   | Min  | Тур  | Max  | Unit  |
|--|------------------------------------|---|------|------|------|-------|
| OFF CHARACTERISTICS                          |                                    |   |      |      |      |       |
| Collector to Emitter Breakdown Voltage       | BV <sub>CES</sub>                  | $V_{GE} = 0 \text{ V}, I_C = 5 \text{ mA}$                            | 1200 | _    | _    | V     |
| Breakdown Voltage Temperature<br>Coefficient | $\Delta BV_{CES}  /  \Delta T_{J}$ | V <sub>GE</sub> = 0 V, I <sub>C</sub> = 5 mA                          | -    | 666  | -    | mV/°C |
| Collector to Emitter Cut-Off<br>Current      | I <sub>CES</sub>                   | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = V <sub>CES</sub>             | -    | -    | 40   | μΑ    |
| Gate to Emitter Leakage Current              | I <sub>GES</sub>                   | V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V                         | -    | -    | ±400 | nA    |
| ON CHARACTERISTICS                           |                                    |   |      |      |      |       |
| Gate to Emitter Threshold Voltage            | V <sub>GE(TH)</sub>                | $V_{GE} = V_{CE}$ , $I_C = 75 \text{ mA}$                             | 5.6  | 6.55 | 7.4  | V     |
| Collector to Emitter Saturation              | V <sub>CE(SAT)</sub>               | V <sub>GE</sub> = 15 V, I <sub>C</sub> = 75 A, T <sub>J</sub> = 25°C  | 1.35 | 1.68 | 2.0  | V     |
| Voltage                                      |                                    | V <sub>GE</sub> = 15 V, I <sub>C</sub> = 75 A, T <sub>J</sub> = 175°C | -    | 2.24 | -    | 1     |
| DYNAMIC CHARACTERISTICS                      |                                    |   |      | •    | •    | •     |
| Input Capacitance                            | C <sub>IES</sub>                   | V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V, f = 1 MHz              | -    | 6331 | -    | pF    |
| Output Capacitance                           | C <sub>OES</sub>                   |   | -    | 234  | -    |       |
| Reverse Transfer Capacitance                 | C <sub>RES</sub>                   |   | -    | 29.6 | -    |       |
| Total Gate Charge                            | $Q_{G}$                            | $V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_{C} = 75 \text{ A}$ | -    | 214  | -    | nC    |
| Gate to Emitter Charge                       | $Q_GE$                             |   | -    | 53.9 | -    |       |
| Gate to Collector Charge                     | Q <sub>GC</sub>                    |   | -    | 77.7 | -    |       |
| SWITCHING CHARACTERISTIC, II                 | NDUCTIVE LOAD                      | )   |      | •    | •    | •     |
| Turn-On Delay Time                           | t <sub>d(on)</sub>                 | $V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$                      | -    | 42   | -    | ns    |
| Turn-Off Delay Time                          | t <sub>d(off)</sub>                | $I_C$ = 37.5 A, $R_G$ = 4.7 Ω, $T_{.1}$ = 25°C                        | -    | 221  | -    | ns    |
| Rise Time                                    | t <sub>r</sub>                     | -   | -    | 27   | -    | ns    |
| Fall Time                                    | t <sub>f</sub>                     |   | -    | 77   | -    | 1     |
| Turn-On Switching Loss                       | E <sub>on</sub>                    |   | -    | 2.12 | -    | mJ    |
| Turn-Off Switching Loss                      | E <sub>off</sub>                   |   | -    | 1.43 | -    | 1     |
| Total Switching Loss                         | E <sub>ts</sub>                    |   | -    | 3.55 | -    | 1     |
| Turn-On Delay Time                           | t <sub>d(on)</sub>                 | $V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$                      | -    | 42   | -    | ns    |
| Turn-Off Delay Time                          | t <sub>d(off)</sub>                | $I_C$ = 75 A, $R_G$ = 4.7 Ω,<br>$T_J$ = 25°C                          | -    | 171  | -    | ns    |
| Rise Time                                    | t <sub>r</sub>                     | -   | -    | 56   | -    | ns    |
| Fall Time                                    | t <sub>f</sub>                     |   | -    | 66   | -    | 1     |
| Turn-On Switching Loss                       | E <sub>on</sub>                    |   | -    | 5.00 | -    | mJ    |
| Turn-Off Switching Loss                      | E <sub>off</sub>                   |   | -    | 2.32 | -    | 1     |
| Total Switching Loss                         | E <sub>ts</sub>                    |   | -    | 7.32 | -    | 1     |
|  |                                    | ı.  |      |      |      |       |

**ELECTRICAL CHARACTERISTICS OF THE IGBT** ( $T_J = 25$ °C unless otherwise noted) (continued)

| Parameter                     | Symbol              | Test Conditions  | Min  | Тур   | Max  | Unit |
|-------------------------------|---------------------|--|------|-------|------|------|
| SWITCHING CHARACTERISTIC, IN  | NDUCTIVE LO         | AD.  | •    |       | •    | -    |
| Turn-On Delay Time            | t <sub>d(on)</sub>  | $V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$   |      | 38    | -    | ns   |
| Turn-Off Delay Time           | t <sub>d(off)</sub> | $I_C$ = 37.5 A, $R_G$ = 4.7 Ω, $I_{-1}$ = 175°C  | -    | 276   | -    | ns   |
| Rise Time                     | t <sub>r</sub>      |  | -    | 26    | -    | ns   |
| Fall Time                     | t <sub>f</sub>      |  | -    | 132   | -    |      |
| Turn-On Switching Loss        | E <sub>on</sub>     |  | -    | 3.50  | -    | mJ   |
| Turn-Off Switching Loss       | E <sub>off</sub>    | 1  | _    | 2.31  | -    |      |
| Total Switching Loss          | E <sub>ts</sub>     |  | -    | 5.81  | -    |      |
| Turn-On Delay Time            | t <sub>d(on)</sub>  | V <sub>CE</sub> = 600 V, V <sub>GE</sub> = 15 V,   | -    | 38    | -    | ns   |
| Turn-Off Delay Time           | t <sub>d(off)</sub> | $I_C$ = 75 A, $R_G$ = 4.7 Ω, $T_J$ = 175°C   | -    | 210   | -    | ns   |
| Rise Time                     | t <sub>r</sub>      | 1  | _    | 53    | -    | ns   |
| Fall Time                     | t <sub>f</sub>      | 1  | _    | 115   | -    |      |
| Turn-On Switching Loss        | E <sub>on</sub>     | 1  | _    | 7.29  | -    | mJ   |
| Turn-Off Switching Loss       | E <sub>off</sub>    |  | -    | 3.50  | -    |      |
| Total Switching Loss          | E <sub>ts</sub>     |  | -    | 10.79 | -    |      |
| DIODE CHARACTERISTIC          |                     |  |      |       |      |      |
| Diode Forward Voltage         | V <sub>F</sub>      | I <sub>F</sub> = 75 A, T <sub>J</sub> = 25°C   | 1.62 | 1.84  | 2.22 | V    |
|                               |                     | I <sub>F</sub> = 75 A, T <sub>J</sub> = 175°C  | =    | 1.91  | -    |      |
| DIODE SWITCHING CHARACTERI    | STIC, INDUCT        | IVE LOAD   |      |       |      |      |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V}, I_F = 37.5 \text{ A}, \\ dI_F/dt = 500 \text{ A}/\mu\text{s}, \\ T_J = 25^{\circ}\text{C}$ | =    | 233   | -    | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     |  | =    | 2343  | -    | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  | -    | 0.8   | -    | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  | =    | 20.2  | -    | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V}, I_F = 75 \text{ A},$   | -    | 307   | -    | nS   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     | $dI_F/dt = 500 A/μs,$ $T_J = 25°C$   | -    | 3285  | -    | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    | 1  | -    | 1     | -    | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  | =    | 21.4  | -    | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V}, I_F = 37.5 \text{ A},$   | -    | 407   | -    | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     | $ dI_F/dt = 500 A/μs, $ $ T_J = 175°C $  | -    | 5965  | -    | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    | 1  | -    | 2     | -    | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    | 7  | -    | 29.4  | -    | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V}, I_F = 75 \text{ A},$   | -    | 541   | -    | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     | dI <sub>F</sub> /dt = 500 A/μs,<br>T <sub>J</sub> = 175°C  | -    | 8974  | -    | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  | -    | 4     | -    | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  | _    | 33.2  | _    | Α    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **TYPICAL CHARACTERISTICS**

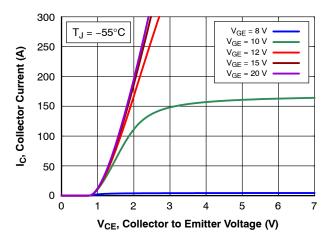


Figure 1. Output Characteristics

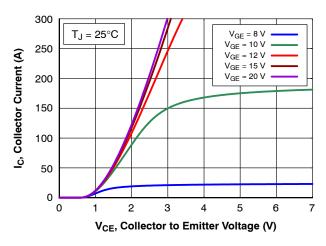


Figure 2. Output Characteristics

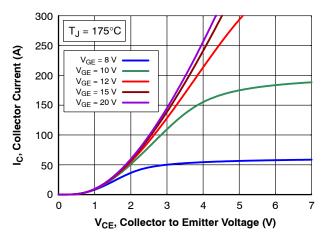


Figure 3. Output Characteristics

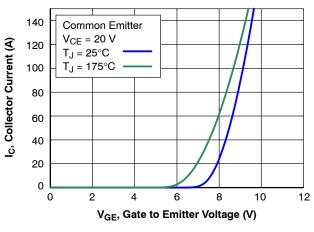


Figure 4. Transfer Characteristics

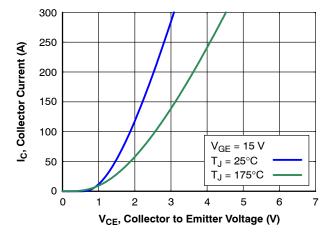


Figure 5. Saturation Voltage Characteristics

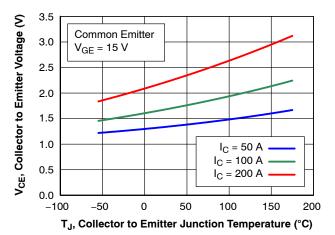


Figure 6. Saturation Voltage vs Junction Temperature

### TYPICAL CHARACTERISTICS (CONTINUED)

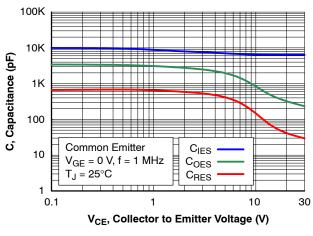


Figure 7. Capacitance Characteristics

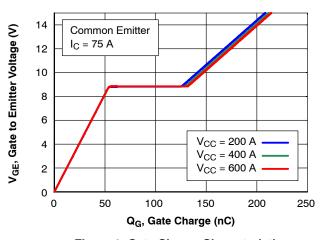


Figure 8. Gate Charge Characteristics

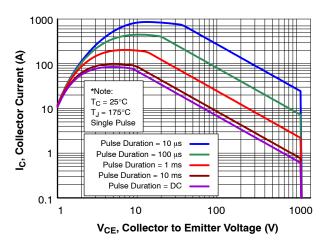


Figure 9. SOA Characteristics

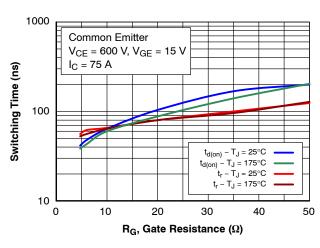


Figure 10. Turn-On Time vs Gate Resistance

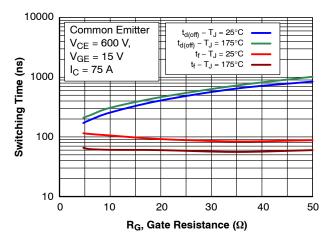


Figure 11. Turn-Off Time vs Gate Resistance

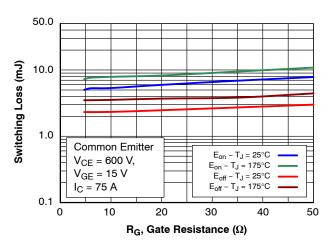


Figure 12. Switching Loss vs Gate Resistance

### TYPICAL CHARACTERISTICS (CONTINUED)

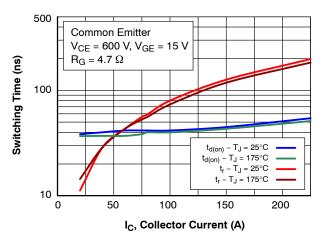


Figure 13. Turn-On Time vs Collector Current

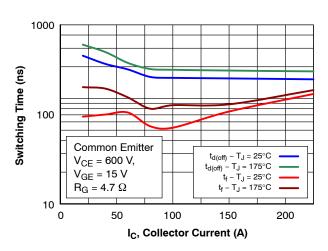


Figure 14. Turn-Off Time vs Collector Current

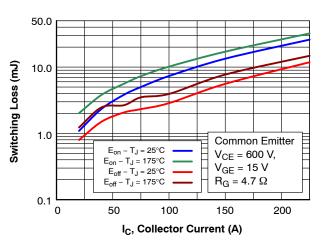


Figure 15. Switching Loss vs Collector Current

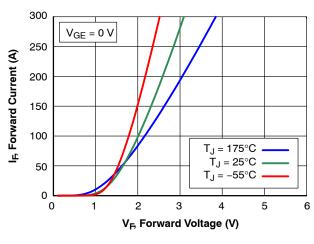


Figure 16. Diode Forward Characteristics

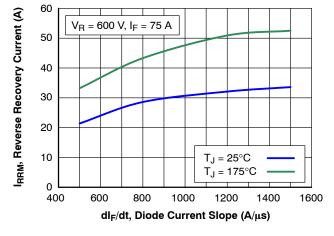


Figure 17. Diode Reverse Recovery Current

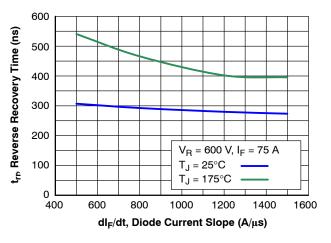


Figure 18. Diode Reverse Recovery Time

# TYPICAL CHARACTERISTICS (CONTINUED)

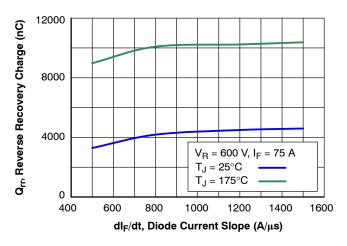


Figure 19. Diode Stored Charge Characteristics

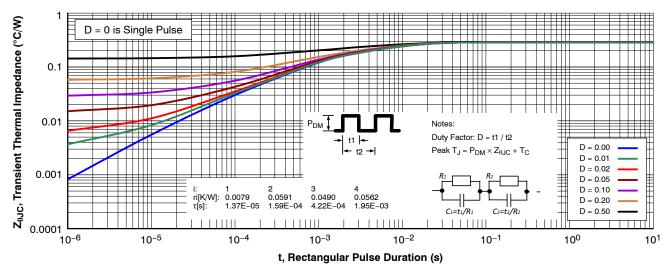


Figure 20. Transient Thermal Impedance of IGBT

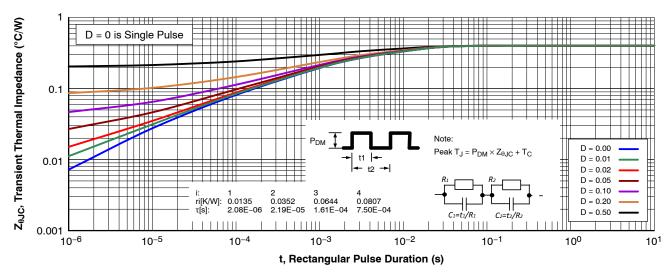


Figure 21. Transient Thermal Impedance of Diode

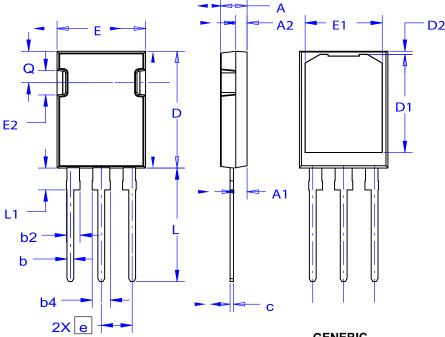


TO-247-3LD CASE 340CD ISSUE A

**DATE 18 SEP 2018** 

### NOTES:

- A. THIS PACKAGE DOES NOT CONFORM TO ANY STANDARDS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.



| DIM        | MILLIMETERS |       |       |  |  |
|------------|-------------|-------|-------|--|--|
| DIM        | MIN         | NOM   | MAX   |  |  |
| Α          | 4.58        | 4.70  | 4.82  |  |  |
| <b>A</b> 1 | 2.20        | 2.40  | 2.60  |  |  |
| A2         | 1.80        | 2.00  | 2.20  |  |  |
| D          | 20.32       | 20.57 | 20.82 |  |  |
| Е          | 15.37       | 15.62 | 15.87 |  |  |
| E2         | 4.12        | 4.32  | 4.52  |  |  |
| е          | ~           | 5.45  | ~     |  |  |
| L          | 19.90       | 20.00 | 20.10 |  |  |
| L1         | 3.69        | 3.81  | 3.93  |  |  |
| Q          | 5.34        | 5.46  | 5.58  |  |  |
| b          | 1.10        | 1.20  | 1.30  |  |  |
| b2         | 2.10        | 2.24  | 2.39  |  |  |
| b4         | 2.87        | 3.04  | 3.20  |  |  |
| С          | 0.51        | 0.61  | 0.71  |  |  |
| D1         | 16.63       | 16.83 | 17.03 |  |  |
| D2         | 0.51        | 0.93  | 1.35  |  |  |
| E1         | 13.40       | 13.60 | 13.80 |  |  |

GENERIC
MARKING DIAGRAM\*

XXXXXXXX AYWWG

XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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|------------------|-------------|---|-------------|--|
| DESCRIPTION:     | TO-247-3LD  |   | PAGE 1 OF 1 |  |

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